

CTK Co., Ltd.

386-1, Ho-dong, Cheoin-gu, Yongin-si, Gyeonggi-do, 449-100, Korea Tel: +82-31-339-9970 Fax: +82-31-339-9855 www.e-ctk.com

EMC TEST REPORT For FCC



Test Report No. : CTK-2012-00686

Date of Issue : July 13, 2012

Model/Type No. : SPES 70W

Kind of Product : SPES

Applicant : KMW INC.

Applicant Address : 183-6 Youngchun-ro, Dongtan-myun, Hwasung-si, Kyungki-do,

Republic of Korea

Manufacturer : KMW INC.

Manufacturer Address : 183-6 Youngchun-ro, Dongtan-myun, Hwasung-si, Kyungki-do,

Republic of Korea

Contact Person : Sung Seok / Principal Research Engineer

Telephone : +81-31-370-8621

Received Date : March 27, 2012

Test Date : June 27, 2012

Test Results : 🛛 In Compliance 🗌 Not in Compliance

The test results presented in this report relate only to the object tested.

Tested by

Bong-jun, Jang EMC Test Engineer Date: July 13, 2012 Reviewed by

James Hong

EMC Technical Manager Date: July 13, 2012

Test Report No.: CTK-2012-00686 Date: July 13, 2012

Form No.: CTK-RF-EF-Part15(Rev.5.7)



REPORT REVISION HISTORY

Date	Revision	Page No
July 13, 2012	Issued (CTK-2012-00686)	All

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1.0 General Product Description

1.0.1 Tested Equipment

\boxtimes	Unless otherwise indicated, all tests were conducted or
	Model SPES 70W.
	Tests performed on Model were considered to be representative of Model

1.0.2 Equipment Size, Mobility and Identification

Dimensions:	626(W) by 104	4.8(D) by 236.5(H)/Includir	ng antenna 🖂 📠
	626(W) by 104	4.8(D) by 86.9(H)/Except for	or the antenna 🛛 🎟
Mobility:	☐ Table-top		☐ Portable Serial
No.: Prot	otype		

1.0.3 Electrical Ratings

[AC/DC ADAPTOR] Input: 100 - 240 Vac, 47-63 Hz

Output: 24 Vdc, 3.0 A

[EUT] Input: 24 Vdc, 3.0 A

Output: -

1.0.4 Test Voltage & Frequency

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

Voltage: 120 Vac Frequency: 60 Hz

1.0.5 Clock & Other Frequencies Utilized

386 ₩z

1.1 Model Differences

Not applicable

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1.2 **Device Modifications**

The following modifications were necessary for compliance and was applied

by applicant.



Core Manufacturer	Part No.	Number of turns	
TAEJIN INT	TR14-13-11	2 Turns	

Component Manufacturer	Part No.	Number of turns	
Dongiltech	CL2-F16-12R	PASS	

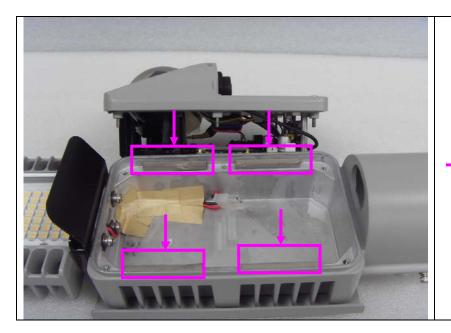
Ground reinforcement

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Gasket tape

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1.3 EUT Configuration(s)

See Appendix B for individual test set-up configuration(s). The following peripheral devices and/or interface cables were connected during the measurement:

Peripheral Devices

Device	Manufacturer	Model No.	Serial No.
AC/DC ADAPTOR1	MEAN WELL Enterprises Co., Ltd.	HLG-80H-24A	-
Note PC	Samsung Electronics Co., Ltd.	NT-R60Y	Z9GJ93GS302109B
AC/DC ADAPTOR2	Samsung ELECTRO-MECHANICS	AD-6019	-
PoE Switch	NETGEAR Inc.	FS108P	1DL29A3B007C9
PoE Switching Adapter	NETGEAR Inc.	DSA-0421S-50	-

□ Cable Description

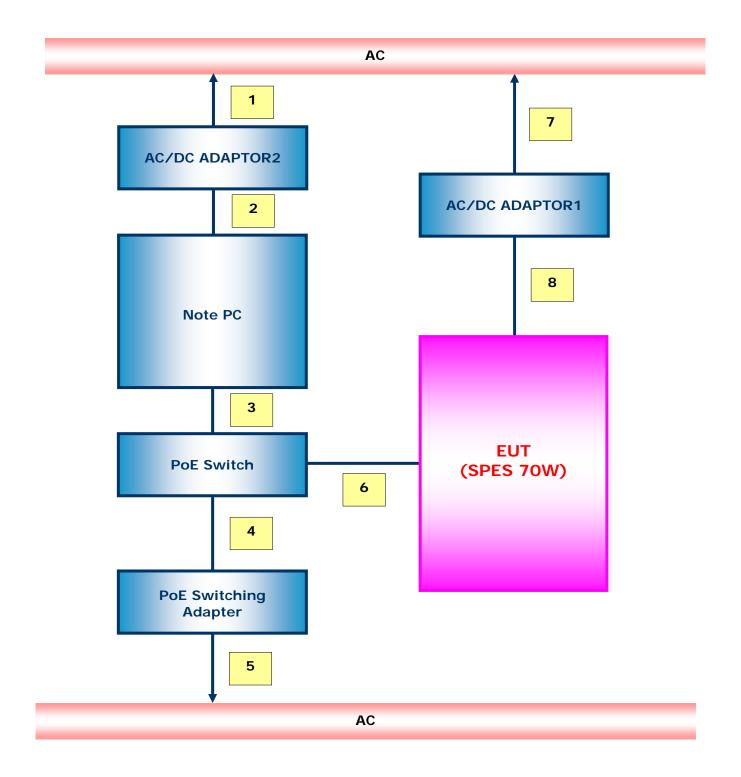
#	Description	Ferrite Core	Length (m)	Other Details
1	AC power Cable, Unshielded	No	1.8	Connect to AC power
2	DC In Cable, Unshielded	No	1.2	Between a Note PC and an AC/DC ADAPTOR2
3	LAN Cable, Shielded	No	1.5	Between a Note PC and a PoE Switch
4	DC In Cable, Unshielded	Yes	1.2	Between a Switch and a PoE Switching Adapter
5	AC power Cable, Unshielded	No	1.8	Connect to AC power
6	LAN Cable, Shielded	No	3.0	Between the EUT and a PoE Switch
7	AC power Cable, Unshielded	No	1.8	Connect to AC power
8	DC In Cable, Unshielded	Yes	1.2	Between the EUT and an AC/DC ADAPTOR1

1.4 Test Software □ EMC Test V 1.0 □ Display Test Patterns – V1.8 □ Ping.exe □ Not applicable 1.5 EUT Operating Mode(s) Equipment under test was operated during the measurement under the following conditions: □ Standby □ Scrolling 'H' □ Display circles pattern □ Display color bar pattern □ Practice operation – Monitoring the EUT's video signal and Ping Test.

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1.6 Configuration



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1.7 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.8 Test Facility

The measurement facility is located at 386-1, Ho-dong, Cheoin-qu, Yongin-si, Gyeonggi-do, 449-100, Korea. The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22.

1.9 Measurement Procedure

Preliminary AC power line conducted emissions tests were performed shielded room. To find worst mode, several typical mode and typical cable position were tested. Final AC power line conducted emissions test was performed shielded room. (location is same as Preliminary test)

Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

Preliminary radiated emissions test were performed semi-anechoic chambers. To find worst mode, several typical mode and typical cable position were tested and peak level and frequency were recorded.

Final radiated emissions test was performed semi-anechoic chambers. Based on the preliminary tests of the EUT, final test was proceeded worst case test mode and cable configuration.

* Measurement procedures was In accordance with ANSI C63.4-2009 7.3.3, 7.3.4, 8.3.1, 8.3.2

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1.10 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 m & 10 m OATS, 3 m & 10 m SAC and Conducted Test Site to perform FCC Part 15/18 measurements	FC 805871
JAPAN	VCCI	10 m OATS, 3 m & 10 m SAC and Conducted Test Site	R-948, C-986, T-1843, R-3627, G-387
KOREA	ксс	EMI (10 m OATS, 10 m SAC and Conducted Test Site) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and Interruptions)	No. 51, KR0025

1.11 Measurement Uncertainty

Compliance of the product is based on the measured value.

However, the measurement uncertainty is included for information purposes. The measurement uncertainties given below are based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately

95 %.

Measurement Type	Frequency Range	Expanded Uncertainty		
Conducted Emission	150 kHz to 30 MHz	\pm 2.48 dB (C.L.: Approx. 95 %, $k=2$)		
Radiated Emission	30 MHz to 1000 MHz	\pm 3.70 dB (C.L.: Approx. 95 %, $k=2$)		

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Emissions Test Regulations 2.0

The emissions tests were performed according to following regulations:			
☐ EN 61000-6-3:2007			
☐ EN 61000-6-4:2007			
☐ EN 55011:2007 +A2:2007	☐ Group 1 ☐ Class A	Group 2 Class B	
☐ EN 55013:2001 +A1:2003 +A2:2006			
☐ EN 55014-1:2006 ☐ EN 55014-1:2006 +A1:2009			
☐ EN 55015:2006 +A1:2007 +A2:2009			
☐ EN 61204-3:2000	☐ Class A	☐ Class B	
☐ EN 61131-2:2007			
☐ EN 61326-1:2006	☐ Class A	☐ Class B	
☐ EN 55022:2006 +A1:2007	☐ Class A	☐ Class B	
☐ EN 61000-3-2:2006 +A1:2009 +A2:2009			
☐ EN 61000-3-3:2008			
☐ VCCI V-3/2011.04	☐ Class A	☐ Class B	
AS/NZS CISPR22: 2009	☐ Class A	☐ Class B	
	☐ Class A	☐ Class B	
CISPR 22: 2006	☐ Class A	☐ Class B	

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Conducted Voltage Emissions 2.1

Test Date

June 27, 2012

Test Location

Shielded Room

Test Equipment

	Name of Equipment	Manufacturer	Model No.	Serial No.	Due Date
\boxtimes	EMI TEST RECEIVER	Rohde & Schwarz	ESCI7	100816	2012-12-16
\boxtimes	LISN	Rohde & Schwarz	ENV216	101235	2012-08-18
\boxtimes	LISN	Rohde & Schwarz	ENV216	101236	2012-08-06
	EMI Test Receiver	Rohde & Schwarz	ESHS30	828144/002	2013-02-09
	LISN	Rohde & Schwarz	ENV216	101150	2013-02-09
	LISN	Rohde & Schwarz	ENV216	101151	2013-02-09

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Results

The requirements are: MET NOT MET NOT APPLICABLE

Frequency (៕½)	Measured Data (dBµV)	Margin (dB)	Remark
0.150 000	48.4	17.6	Quasi-peak

Remarks

See Appendix A for test data.

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2.2 **Radiated Electric Field Emissions**

Test Date	
June 27, 2012	
Test Location	
Testing was performed	at a test distance of:
10 m OATS	3 m OATS
	☑ 3 m SAC

Test Equipment

	Name of Equipment	Manufacturer	Model No.	Serial No.	Due Date	
 $\mathbb X$	EMI TEST RECEIVER	Rohde & Schwarz	ESCI7	100814	2012-12-13	
X	ULTRA Broadband Antenna	Rohde & Schwarz	HL562	100203	2013-07-05	
\boxtimes	AMPLIFIER	Sonoma Instrument Co.	310	291721	2013-03-27	
$\mathbb M$	EMI TEST RECEIVER	Rohde & Schwarz	ESCI7	100816	2012-12-16	
\boxtimes	Double Ridged Guide Antenna	ETS-Lindgren	3115	00078894	2013-03-22	
X	PREAMPLIFIER	Agilent Technologies	8449B	3008A02307	2012-11-17	

Frequency Range of Measurement

□ 1 日本 to 2 日本

Instrument Settings

Test Results

The requirements are: MET NOT MET NOT APPLICABLE

Frequency (\mu)	Measured Data (dBμV/m)	Margin (dB)	Remark
957.320	41.8	4.2	Quasi-peak

Remarks

See Appendix A for test data.

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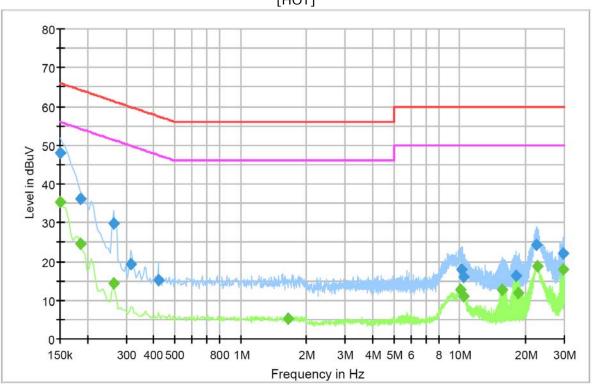
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APPENDIX A - TEST DATA

Conducted Voltage Emissions





Final Result 1

Frequency (MHz)	QuasiPeak (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)
0.150000	48.0	1000.0	9.000	On	L1	10.2	18.0	66.0
0.186000	36.1	1000.0	9.000	On	L1	10.0	28.1	64.2
0.262500	29.9	1000.0	9.000	On	L1	10.1	31.5	61.4
0.316500	19.4	1000.0	9.000	On	L1	10.0	40.4	59.8
0.420000	15.3	1000.0	9.000	On	L1	10.0	42.2	57.4
10.149000	17.8	1000.0	9.000	On	L1	9.7	42.2	60.0
10.437000	16.0	1000.0	9.000	On	L1	9.7	44.0	60.0
18.159000	16.2	1000.0	9.000	On	L1	9.8	43.8	60.0
22.353000	24.2	1000.0	9.000	On	L1	9.9	35.8	60.0
29.787000	22.1	1000.0	9.000	On	L1	10.0	37.9	60.0

Final Result 2

man Rooan =										
Frequency (MHz)	Average (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)		
0.150000	35.3	1000.0	9.000	On	L1	10.2	20.7	56.0		
0.186000	24.6	1000.0	9.000	On	L1	10.0	29.6	54.2		
0.262500	14.2	1000.0	9.000	On	L1	10.1	37.1	51.4		
1.639500	5.1	1000.0	9.000	On	L1	9.9	40.9	46.0		
10.059000	12.6	1000.0	9.000	On	L1	9.7	37.4	50.0		
10.468500	11.1	1000.0	9.000	On	L1	9.7	38.9	50.0		
15.634500	12.7	1000.0	9.000	On	L1	9.8	37.3	50.0		
18.415500	11.8	1000.0	9.000	On	L1	9.8	38.2	50.0		
22.596000	18.9	1000.0	9.000	On	L1	9.9	31.2	50.0		
29.782500	17.9	1000.0	9.000	On	L1	10.0	32.1	50.0		

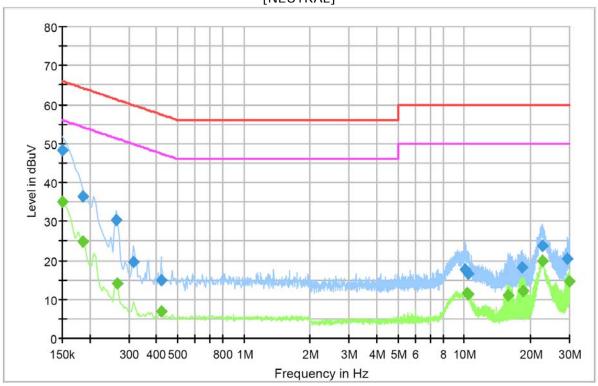
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[NEUTRAL]



Final Result 1

Frequency	QuasiPeak	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dBuV)	Time (ms)	(kHz)			(dB)	(dB)	(dBuV)
0.150000	48.4	1000.0	9.000	On	N	10.2	17.6	66.0
0.186000	36.4	1000.0	9.000	On	N	10.1	27.8	64.2
0.262500	30.3	1000.0	9.000	On	N	10.1	31.1	61.4
0.316500	19.5	1000.0	9.000	On	N	10.0	40.3	59.8
0.420000	15.0	1000.0	9.000	On	N	10.0	42.5	57.4
10.054500	17.6	1000.0	9.000	On	N	9.7	42.4	60.0
10.414500	16.4	1000.0	9.000	On	N	9.7	43.6	60.0
18.357000	18.3	1000.0	9.000	On	N	9.9	41.7	60.0
22.762500	23.8	1000.0	9.000	On	N	10.0	36.2	60.0
29.278500	20.3	1000.0	9.000	On	N	10.2	39.7	60.0

Final Result 2

Frequency (MHz)	Average (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)
0.150000	35.0	1000.0	9.000	On	N	10.2	21.0	56.0
0.186000	24.8	1000.0	9.000	On	N	10.1	29.4	54.2
0.267000	14.0	1000.0	9.000	On	N	10.1	37.2	51.2
0.420000	6.9	1000.0	9.000	On	N	10.0	40.6	47.4
10.324500	11.7	1000.0	9.000	On	N	9.7	38.3	50.0
10.410000	11.4	1000.0	9.000	On	N	9.7	38.6	50.0
15.774000	11.0	1000.0	9.000	On	N	9.8	39.0	50.0
18.424500	12.0	1000.0	9.000	On	N	9.9	38.0	50.0
22.555500	19.8	1000.0	9.000	On	N	10.0	30.2	50.0
29.994000	14.7	1000.0	9.000	On	N	10.2	35.3	50.0

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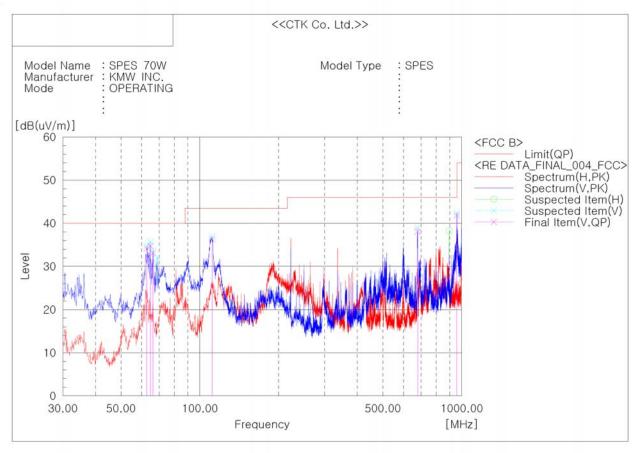
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Radiated Electric Field Emissions

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nol	Dagui	1
Hal	Resul	

No.	Frequency	(P)	Reading QP	c.f	Result QP	Limit QP	Margin QP	Height	Angle
	[MHz]		[dB(uV)]	[dB(1/m)]	[dB(uV/m)]	[dB(uV/m)]	[dB]	[cm]	[deg]
1	62.738	V	60.2	-26.0	34.2	40.0	5.8	193.0	102.0
2	64.799	V	60.3	-25.6	34.7	40.0	5.3	100.0	70.0
3	66.254	V	58.4	-25.3	33.1	40.0	6.9	193.0	0.0
4	111.601	V	56.1	-19.8	36.3	43.5	7.2	100.0	144.0
5	679.536	V	45.3	-7.2	38.1	46.0	7.9	100.0	181.0
6	957.320	V	43.7	-1.9	41.8	46.0	4.2	100.0	0.0

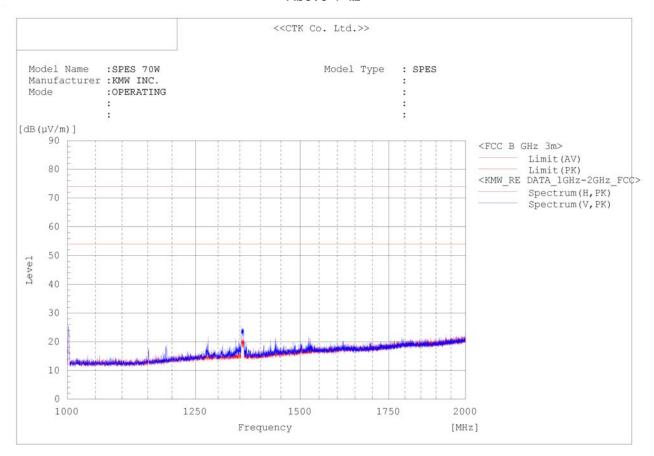
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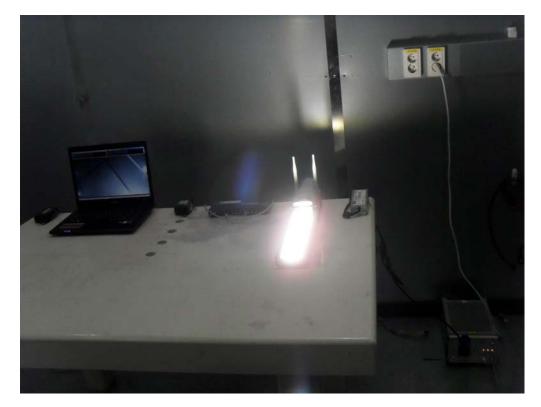


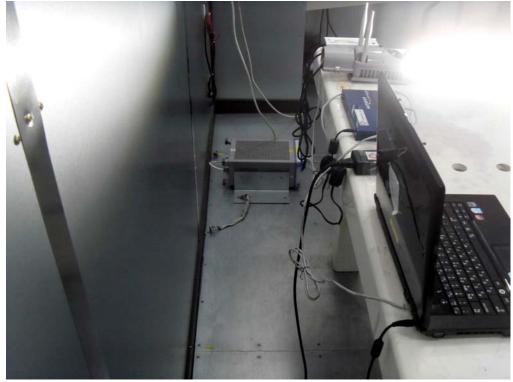
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APPENDIX B - Test Setup Photos and Configuration

Conducted Voltage Emissions



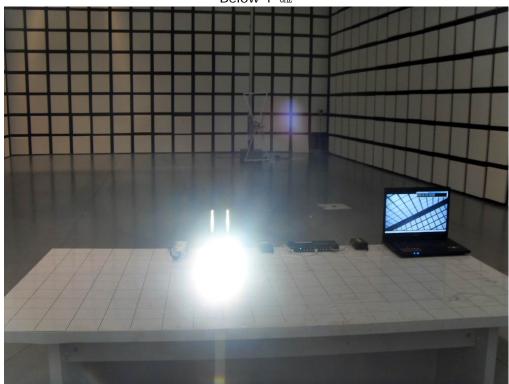


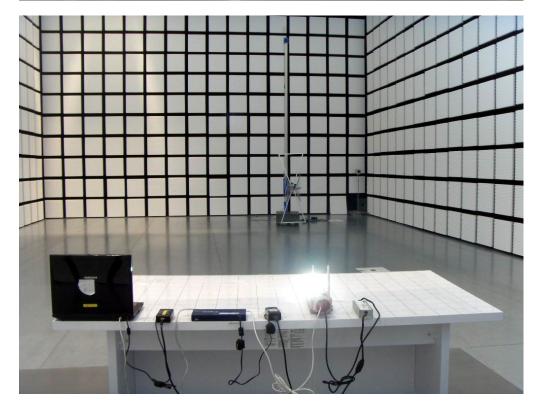
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Radiated Electric Field Emissions





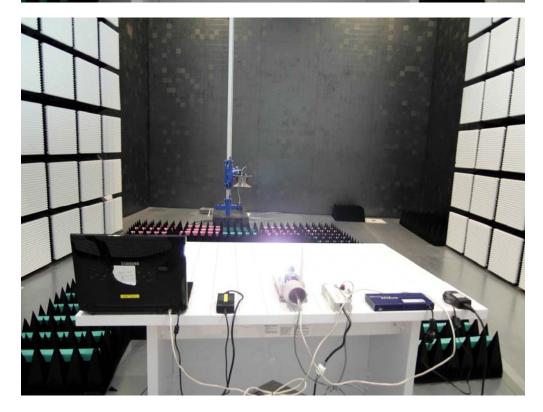


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APPENDIX C – EUT Photographs

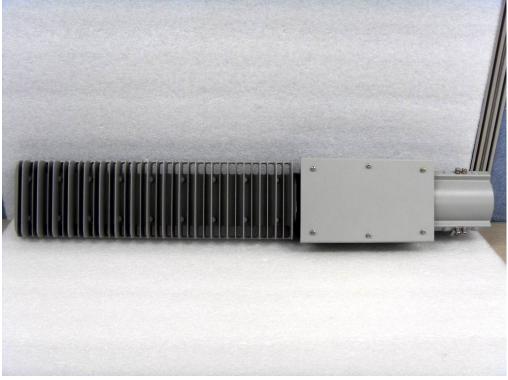
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EUT External Photographs



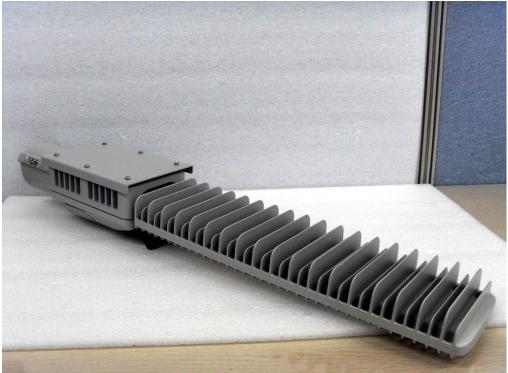


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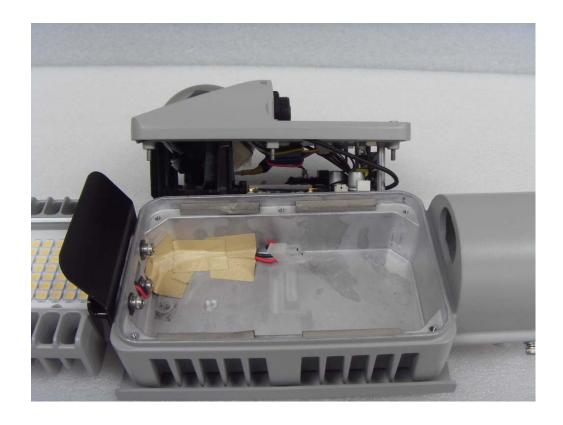


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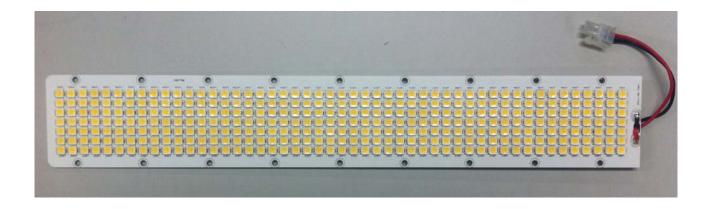
EUT Internal Photographs

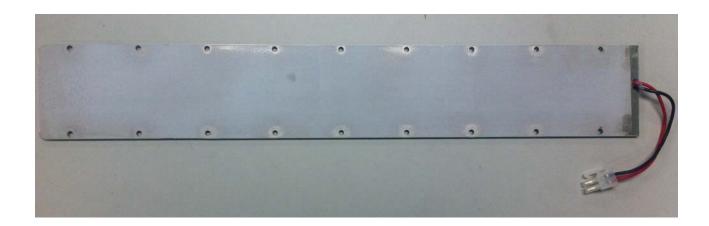


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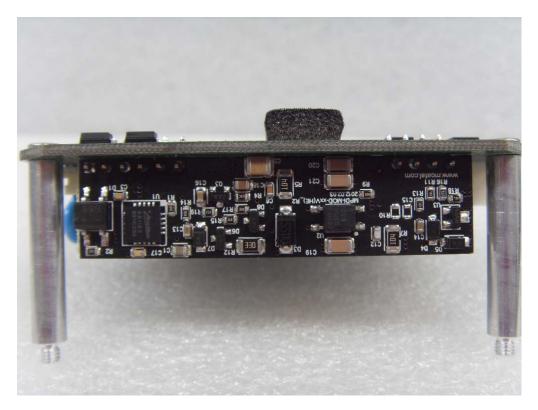
PCB

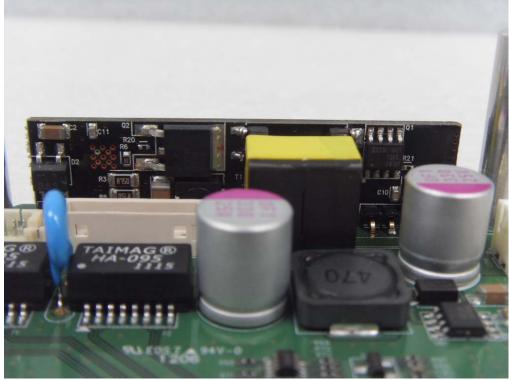




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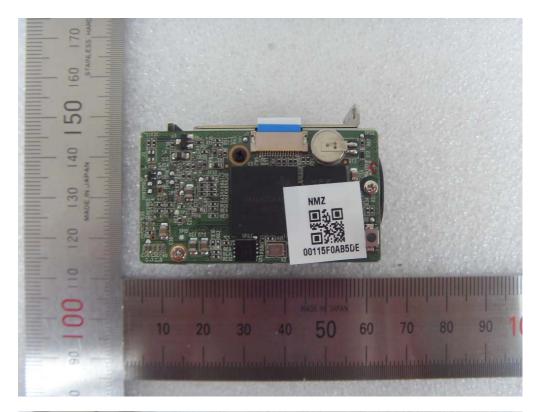


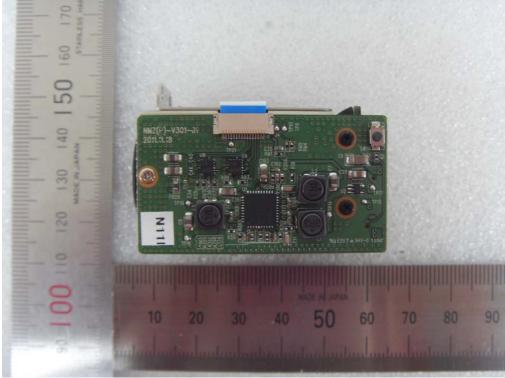


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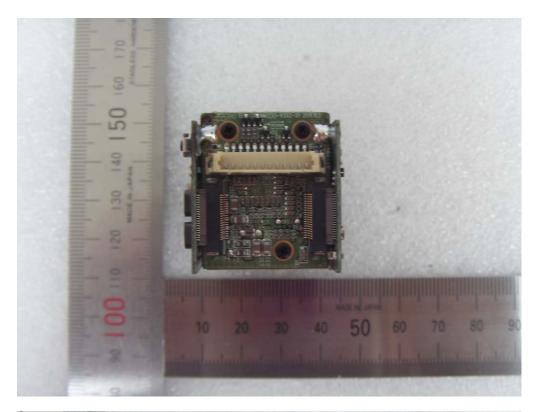
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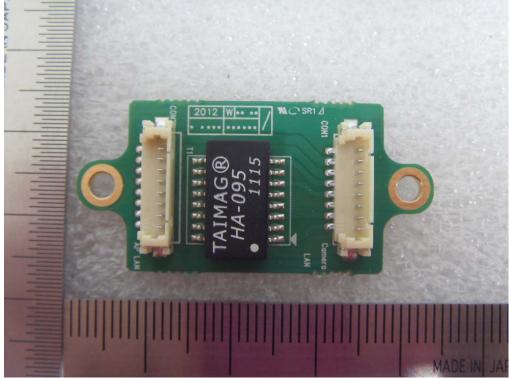
Date: July 13, 2012



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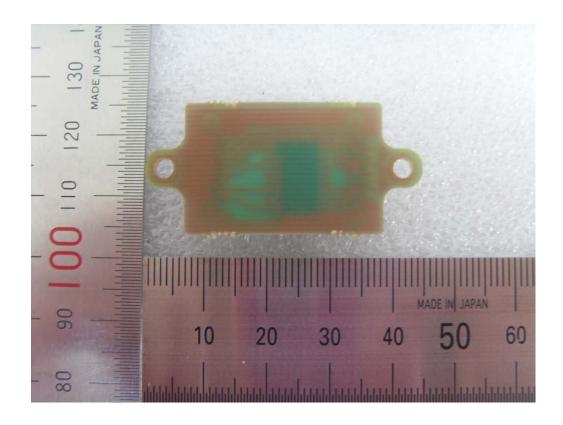




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AC/DC ADAPTOR

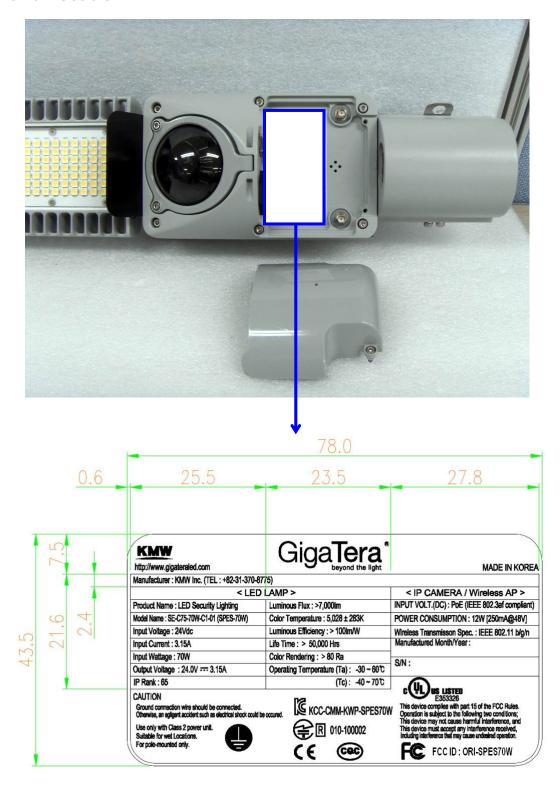




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Label and Location



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